



9Amps, 30 Volts
N-CHANNEL POWER MOSFET

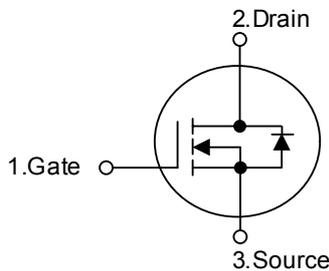
■ DESCRIPTION

The YR 09N03 is a low voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and excellent avalanche characteristics. This power MOSFET is usually used at automotive applications in power supplies, high efficient DC to DC converters and battery operated products.

■ FEATURES

- * $R_{DS(ON)} = 28m\Omega @ V_{GS} = 10V$
- * Ultra low gate charge (typical 7 nC)
- * Low reverse transfer Capacitance ($C_{RSS} =$ typical 70 pF)
- * Fast switching capability
- * 100% avalanche energy specified
- * Improved dv/dt capability

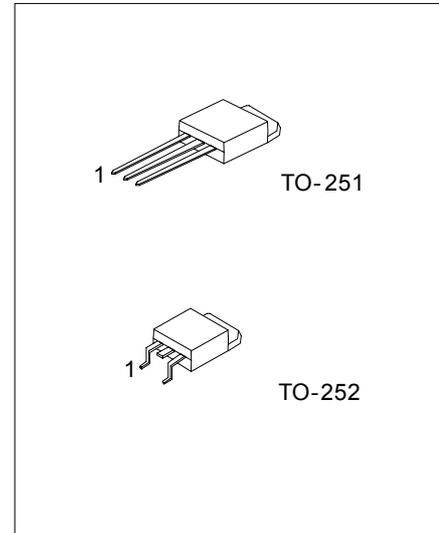
■ SYMBOL



■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current	I_D	$T_A = 25^\circ C$	9.0
		$T_A = 70^\circ C$	7.6
Pulsed Drain Current ^C	I_{DM}	35	A
Power Dissipation ^B	P_D	$T_A = 25^\circ C$	1.6
		$T_A = 70^\circ C$	1.1
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ C$

Thermal Characteristics					
Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$t \leq 10s$	$R_{\theta JA}$	70	90	$^\circ C/W$
	Steady-State		100	125	$^\circ C/W$
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	$^\circ C/W$



*Pb-free plating product number: YR09N03

■ ELECTRICAL CHARACTERISTICS ($T_C = 25$, unless otherwise specified)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V$ $T_J=55^\circ C$			1 5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 12V$			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	0.65	1.05	1.45	V
$I_{D(ON)}$	On state drain current	$V_{GS}=4.5V, V_{DS}=5V$	30			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=5.8A$ $T_J=125^\circ C$		18 28	28 39	m Ω
		$V_{GS}=4.5V, I_D=5A$		19	33	m Ω
		$V_{GS}=2.5V, I_D=4A$		24	52	m Ω
g_{FS}	Forward Transconductance	$V_{DS}=5V, I_D=5.8A$		33		S
V_{SD}	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.7	1	V
I_S	Maximum Body-Diode Continuous Current				2	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=15V, f=1MHz$	500	630	760	pF
C_{oss}	Output Capacitance		50	75	100	pF
C_{riss}	Reverse Transfer Capacitance		30	50	70	pF
R_g	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	1.5	3	4.5	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=4.5V, V_{DS}=15V, I_D=5.8A$	4.8	6	7	nC
Q_{gs}	Gate Source Charge		1	1.3	1.6	nC
Q_{gd}	Gate Drain Charge		1	1.8	2.5	nC
$t_{D(on)}$	Turn-On DelayTime	$V_{GS}=10V, V_{DS}=15V, R_L=2.6\Omega,$ $R_{GEN}=3\Omega$		3		ns
t_r	Turn-On Rise Time			2.5		ns
$t_{D(off)}$	Turn-Off DelayTime			25		ns
t_f	Turn-Off Fall Time			4		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=5.8A, di/dt=100A/\mu s$	7	8.5	10	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=5.8A, di/dt=100A/\mu s$	2	2.6	3.1	nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ C$. The value in any given application depends on the user's specific board design.

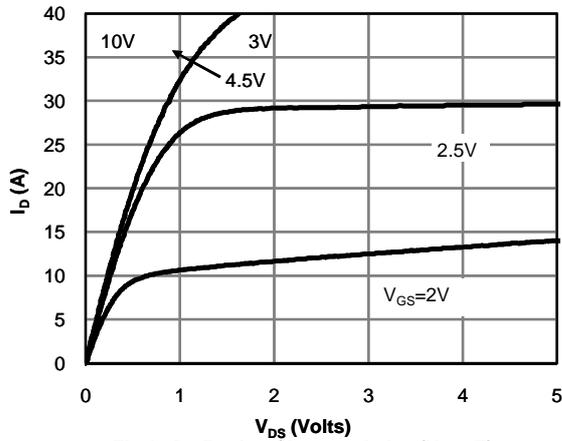
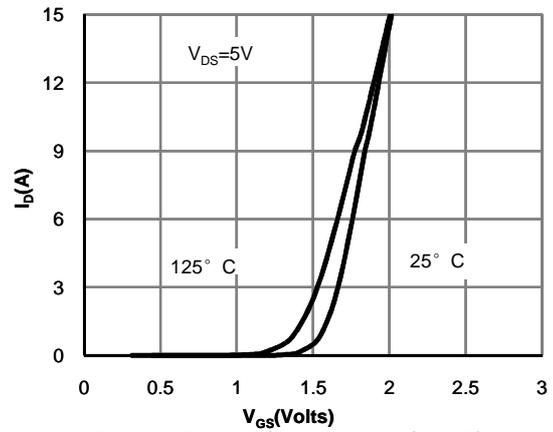
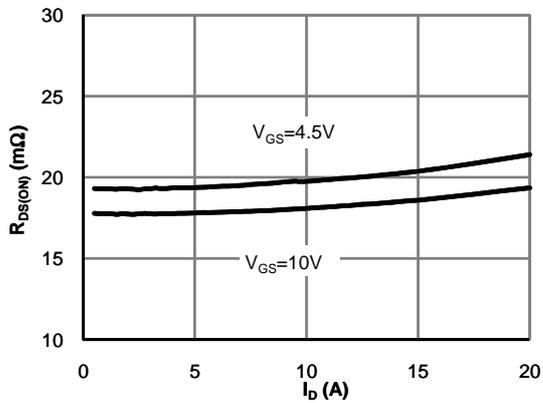
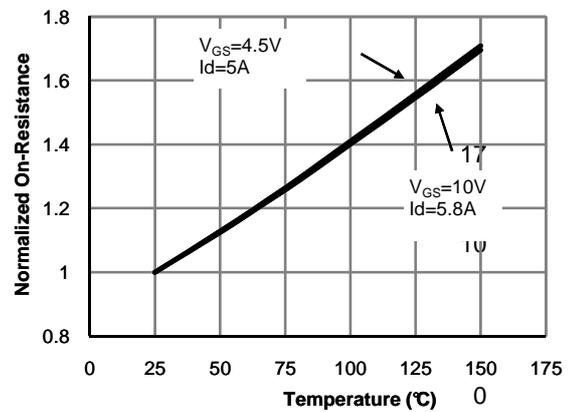
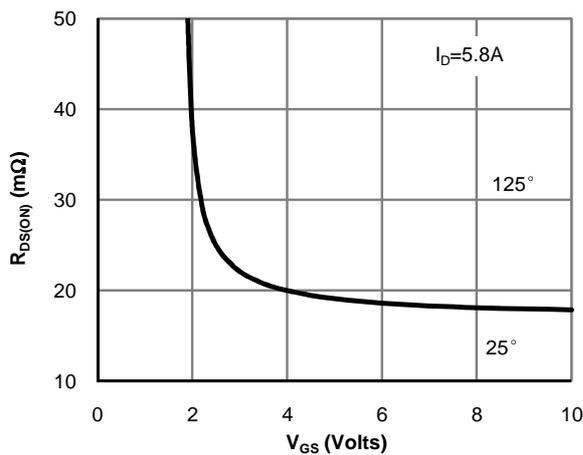
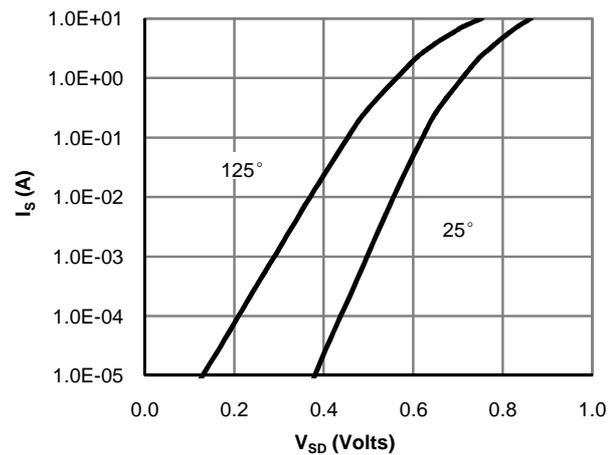
B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ C$, using $\leq 10s$ junction-to-ambient thermal resistance.

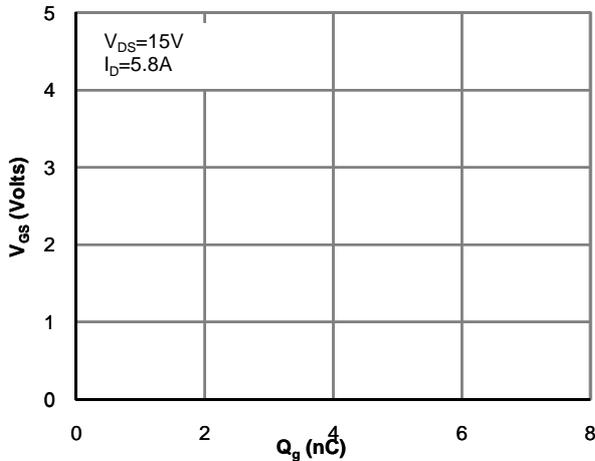
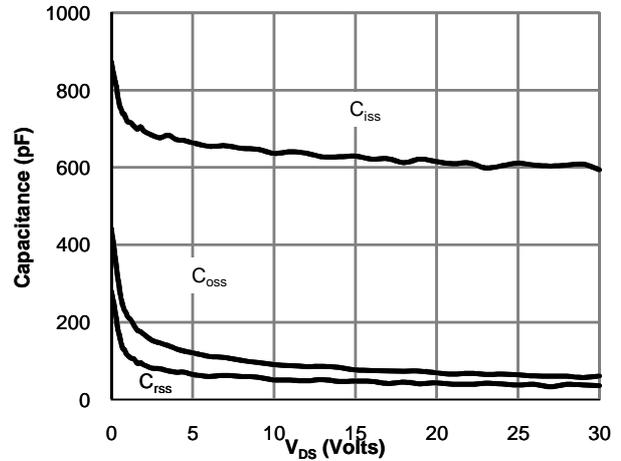
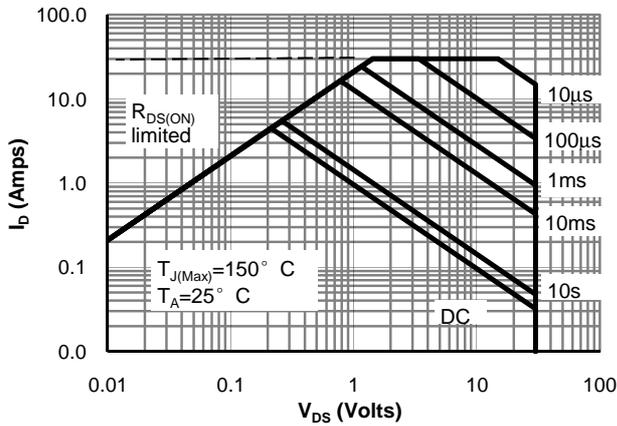
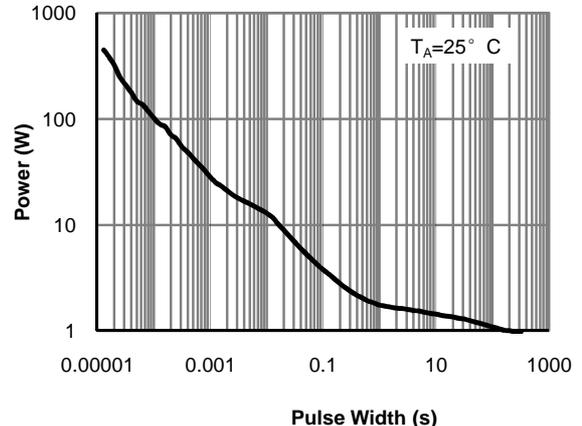
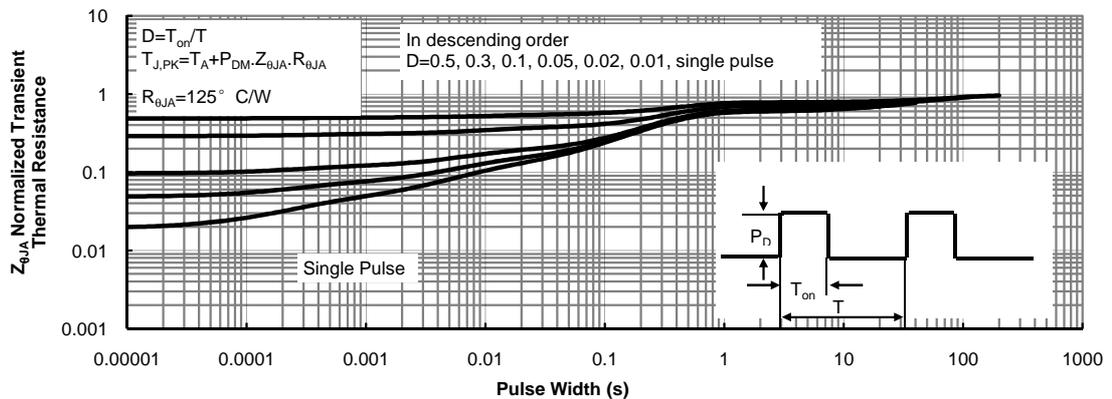
C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ C$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ C$.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

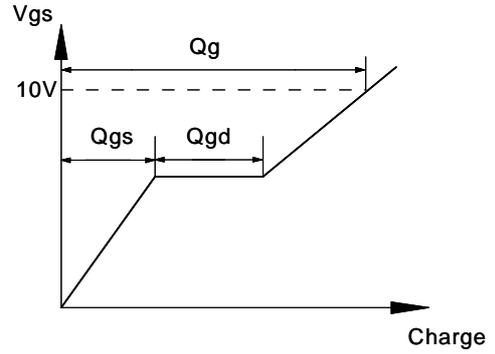
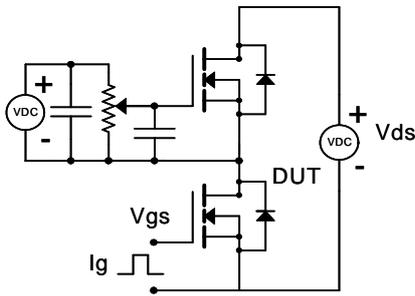
E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu s$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}=150^\circ C$. The SOA curve provides a single pulse rating.

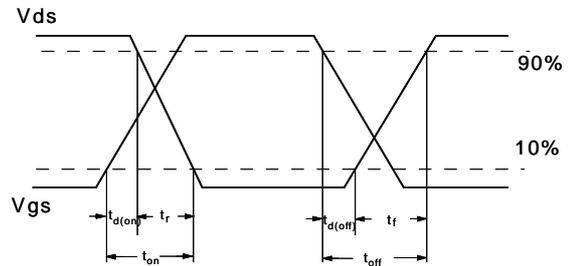
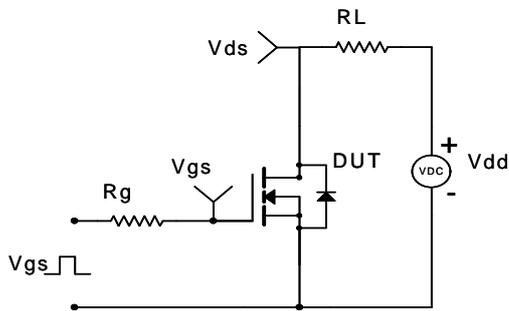
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Fig 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

